

1200V, 25A,  $V_{_{ce(on)}}\,$  = 2.5V Typical

# Ultra Fast NPT - IGBT®

The Ultra Fast NPT - IGBT<sup>®</sup> family of products is the newest generation of planar IGBTs optimized for outstanding ruggedness and the best trade-off between conduction and switching losses.

## **Features**

- Low Saturation Voltage
- Low Tail Current
- RoHS Compliant *M*

- Short Circuit Withstand Rated
- High Frequency Switching
- Ultra Low Leakage Current

Unless stated otherwise, Microsemi discrete IGBTs contain a single IGBT die. This device is recommended for applications such as induction heating (IH), motor control, general purpose inverters and uninterruptible power supplies (UPS).

### MAXIMUM RATINGS

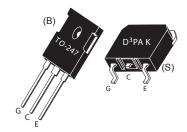
All Ratings:  $T_c = 25^{\circ}C$  unless otherwise specified.

Symbol	Parameter	Ratings	Unit	
V <sub>ces</sub>	Collector Emitter Voltage	1200	V	
$V_{GE}$	Gate-Emitter Voltage	±30	V	
I <sub>C1</sub>	Continuous Collector Current @ $T_c$ = 25°C	75		
I <sub>C2</sub>	Continuous Collector Current @ T <sub>c</sub> = 125°C	25	А	
I <sub>CM</sub>	Pulsed Collector Current ①	100		
SCWT	Short Circuit Withstand Time: $V_{ce}$ = 600V, $V_{ge}$ = 15V, $T_c$ = 125°C	10	μs	
P <sub>D</sub>	Total Power Dissipation @ $T_c = 25^{\circ}C$	521	W	
T_,T <sub>stg</sub>	Operating and Storage Junction Temperature Range	-55 to 150		
TL	Max. Lead Temp. for Soldering: 0.063" from Case for 10 Sec.	300	°C	

## STATIC ELECTRICAL CHARACTERISTICS

Symbol	Parameter	Min	Тур	Max	Unit
V <sub>(BR)CES</sub>	Collector-Emitter Breakdown Voltage ( $V_{GE} = 0V$ , $I_{C} = 500\mu$ A)	1200			
V <sub>GE(TH)</sub>	Gate Threshold Voltage ( $V_{CE} = V_{GE}$ , $I_{C} = 1.0$ mA, $T_{j} = 25$ °C)	3.5	5.0	6.5	) ( - H -
V <sub>CE(ON)</sub>	Collector-Emitter On Voltage ( $V_{GE}$ = 15V, $I_{c}$ = 25A, $T_{j}$ = 25°C)		2.5	3.2	Volts
	Collector-Emitter On Voltage ( $V_{GE}$ = 15V, $I_{c}$ = 25A, $T_{j}$ = 125°C)		3.3		
	Collector-Emitter On Voltage ( $V_{GE}$ = 15V, $I_{c}$ = 50A, $T_{j}$ = 25°C)		3.5		
I <sub>ces</sub>	Collector Cut-off Current (V <sub>CE</sub> = 1200V, V <sub>GE</sub> = 0V, T <sub>j</sub> = 25°C) <sup>(2)</sup>		5	500	μA
020	Collector Cut-off Current (V <sub>CE</sub> = 1200V, V <sub>GE</sub> = 0V, T <sub>j</sub> = 125°C) <sup>(2)</sup>		50		
I <sub>GES</sub>	Gate-Emitter Leakage Current (V <sub>GE</sub> = ±20V)			±250	nA

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.





#### **DYNAMIC CHARACTERISTICS**

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
C <sub>ies</sub>	Input Capacitance	Capacitance	İ	2784		
C <sub>oes</sub>	Output Capacitance	$V_{GE} = 0V, V_{CE} = 25V$ f = 1MHz		271		рF
C <sub>res</sub>	Reverse Transfer Capacitance			75		
V <sub>GEP</sub>	Gate to Emitter Plateau Voltage		1	7.5		V
Q <sub>g</sub> ③	Total Gate Charge	Gate Charge		154	203	
Q <sub>ge</sub>	Gate-Emitter Charge	V <sub>GE</sub> = 15V		20	27	0
Q <sub>gc</sub>	Gate- Collector Charge	- V <sub>CE</sub> = 600V - I <sub>C</sub> = 25A		76	97	nC
t <sub>d(on)</sub>	Turn-On Delay Time	Inductive Switching (25°C)	1	16		
t <sub>r</sub>	Current Rise Time	V <sub>cc</sub> = 600V		10		20
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>gE</sub> = 15V		122		ns
t <sub>r</sub>	Current Fall Time	l <sub>c</sub> = 25A		20		
E <sub>on2</sub> 5	Turn-On Switching Energy	$R_{G} = 4.3 \ \Omega^{(4)}$		742	1110	
E <sub>off</sub>	Turn-Off Switching Energy	T <sub>J</sub> = +25°C		427	640	μJ
t <sub>d(on)</sub>	Turn-On Delay Time	Inductive Switching (125°C)		16		
t	Current Rise Time	V <sub>cc</sub> = 600V		10		
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>GE</sub> = 15V		136		ns
t <sub>r</sub>	Current Fall Time	I <sub>c</sub> = 25A		28		
E <sub>on2</sub> 5	Turn-On Switching Energy	$R_{g} = 4.3 \ \Omega^{(4)}$		1297	1945	
E <sub>off</sub>	Turn-Off Switching Energy	T_= +125°C		480	720	μJ

## THERMAL AND MECHANICAL CHARACTERISTICS

Symbol	Characteristic	Min	Тур	Max	Unit
R <sub>ejc</sub>	Junction to Case Thermal Resistance			.24	°C/W
R <sub>eja</sub>	Junction to Ambient Thermal Resistance			40	
W <sub>T</sub>	Package Weight		.22		oz
			6.2		g
Torque	Mounting Torque (TO-247 Package), 4-40 or M3 screw			10	in-lbf
				6.2	N∙m

1 Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.

2 Pulse test: Pulse Width <  $380\mu s$ , duty cycle < 2%.

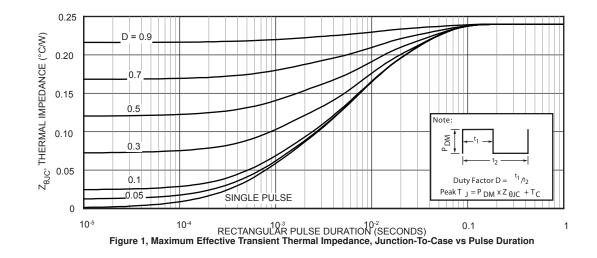
3 See Mil-Std-750 Method 3471.

4 R<sub>G</sub> is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)

5 E<sub>on2</sub> is the clamped inductive turn on energy that includes a commutating diode reverse recovery current in the IGBT turn on energy loss. A combi device is used for the clamping diode.

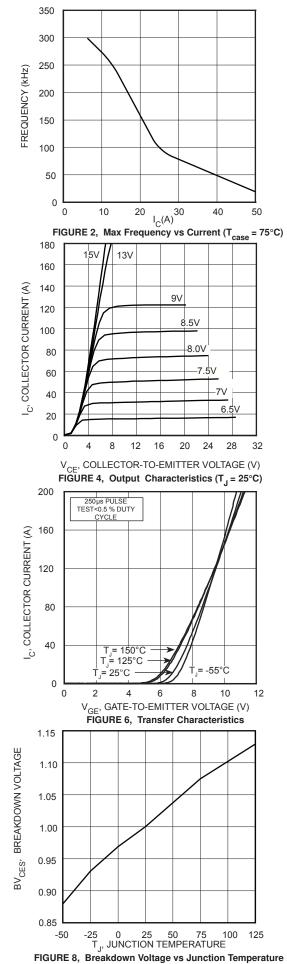
6 E<sub>off</sub> is the clamped inductive turn-off energy measured in accordance with JEDEC standard JESD24-1.

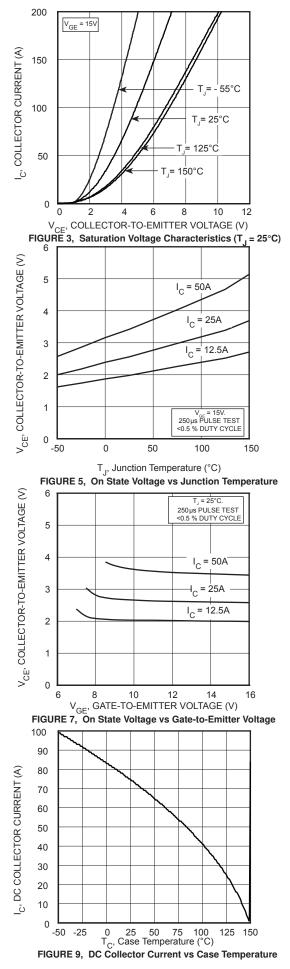
Microsemi reserves the right to change, without notice, the specifications and information contained herein.



#### **TYPICAL PERFORMANCE CURVES**

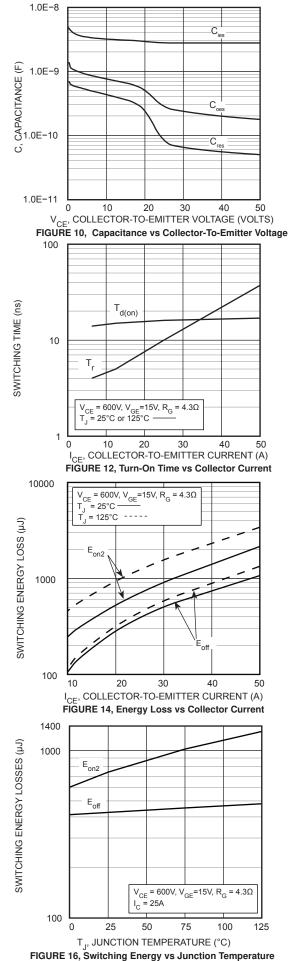
APT25GR120B S

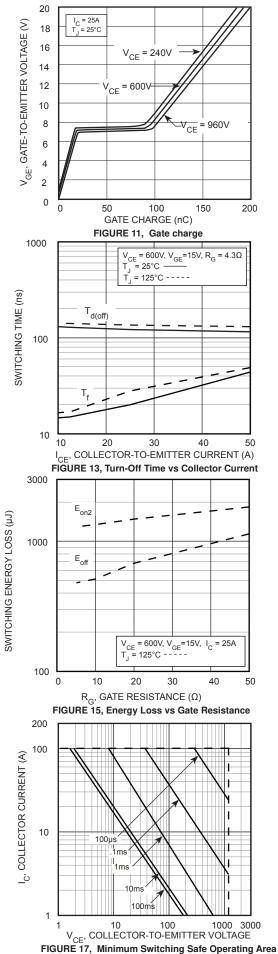






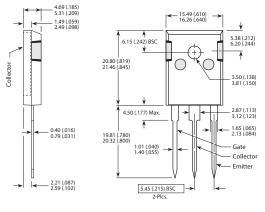








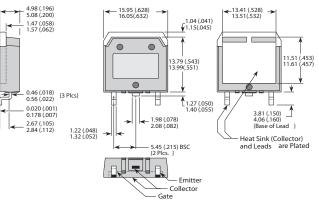
## **TO-247 Package Outline**



Dimensions in Millimeters (Inches)



Collector (Heat Sink)



Dimensions in Millimeters (Inches)

The information contained in the document (unless it is publicly available on the Web without access restrictions) is PROPRIETARY AND CONFIDENTIAL information of Microsemi and cannot be copied, published, uploaded, posted, transmitted, distributed or disclosed or used without the express duly signed written consent of Microsemi. If the recipient of this document has entered into a disclosure agreement with Microsemi, then the terms of such Agreement will also apply. This document and the information contained herein may not be modified, by any person other than authorized personnel of Microsemi. No license under any patent, copyright, trade secret or other intellectual property right is granted to or conferred upon you by disclosure or delivery of the information, either expressly, by implication, inducement, estoppels or otherwise. Any license under such intellectual property rights must be approved by Microsemi in writing signed by an officer of Microsemi.

Microsemi reserves the right to change the configuration, functionality and performance of its products at anytime without any notice. This product has been subject to limited testing and should not be used in conjunction with life-support or other mission-critical equipment or applications. Microsemi assumes no liability whatsoever, and Microsemi disclaims any express or implied warranty, relating to sale and/or use of Microsemi products including liability or warranties relating to fitness for a particular purpose, merchantability, or infringement of any patent, copyright or other intellectual property right. Any performance specifications believed to be reliable but are not verified and customer or user must conduct and complete all performance and other testing of this product as well as any user or customers final application. User or customer shall not rely on any data and performance specifications or parameters provided by Microsemi. It is the customer's and user's responsibility to independently determine suitability of any Microsemi product and to test and verify the same. The information contained herein is provided "AS IS, WHERE IS" and with all faults, and the entire risk associated with such information is entirely with the User. Microsemi specifically disclaims any liability of any kind including for consequential, incidental and punitive damages as well as lost profit. The product is subject to other terms and conditions which can be located on the web at http://www.microsemi.com/legal/tnc.asp